

<b>Search Notes</b> 	<b>Application/Control No.</b> 09/545,769	<b>Applicant(s)/Patent under Reexamination</b> BEYDA ET AL.
	<b>Examiner</b> Shick C. Horn	<b>Art Unit</b> 2616

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	230, 235,	4/30/2006	SH
370	252, 392,	4/30/2006	SH
370	396, 465,	4/30/2006	SH
370/395.31, 395.42, 395.43, 395.52, 395.6, 395.61, 395.65,		4/30/2006	SH

Search Notes (continued)	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/545,769	BEYDA ET AL.
Examiner	Art Unit	
Shick C. Hom	2616	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	468, 401,	4/30/2006	SH
370	395.21,	4/30/2006	SH
370	402, 469	4/30/2006	SH
709/223, 227, 228, 232		4/30/2006	SH